## Notice of References Cited Application/Control No. 09/775,715 Applicant(s)/Patent Under Reexamination ABROL ET AL. Examiner Chongshan Chen Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	. Date MM-YYYY	Name	Classification
	Α	US-5,855,015	12-1998	Shoham, Yoav	707/5
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Η	US-			
	ı	US-			·
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000090109	03-2000	Japan	WADA ET AL.	G06F 17/30
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.